

N-Channel 650V MOSFET

Product summary

V_{DS} (V)	$R_{DS(on),max}$ (m Ω)	I_D (A)
650	70 @ $V_{GS} = 10V$	47 ⁽¹⁾

Features

- Low $R_{DS(on)}$ and FOM
- Low Switching loss
- 100% avalanche tested. High avalanche ruggedness
- Ultra-fast and robust body diode

Applications

- Telecom / Server Power Supplies
- Industrial Power Supplies
- EV Charger
- UPS / Solar

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Package and ordering information

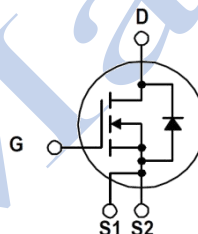
Ordering code	Package	Device code
SDH65N070QF-AA	TOLL2	AOF

1. Maximum ratings

Absolute maximum ratings ($T_A = 25^\circ\text{C}$ unless otherwise noted)

Parameter		Symbol	Limit	Unit
Drain-source voltage		V_{DS}	650	V
Gate-source voltage		V_{GS}	± 30	V
Continuous drain current ⁽¹⁾	$T_C = 25^\circ\text{C}^{(1)}$	I_D	47	A
	$T_C = 100^\circ\text{C}^{(1)}$		30	
Pulsed drain current ⁽²⁾		$I_{D,pulse}$	188	
Avalanche energy, single pulse ⁽³⁾		E_{AS}	810	mJ
Power dissipation	$T_C = 25^\circ\text{C}$	P_D	357	W
Operating junction and storage temperature range		T_J, T_{stg}	-55 to 150	$^\circ\text{C}$

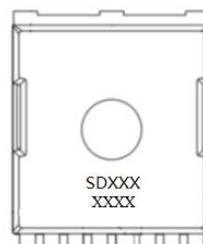
TOLL2



S1 : Driver Source
S2 : Power Source



RoHS
COMPLIANT
HALOGEN
FREE



SDXXX
└─ Device code
└─ Silicon Magic discrete device

XXXX
└─ Wafer lot number
└─ Work week code
└─ Year code

2. Thermal resistance ratings

Thermal resistance ratings						
Parameter ⁽⁴⁾		Symbol	Max.	Unit		
Thermal resistance, junction-to-case	Steady state	$R_{\theta JC}$	0.35	°C/W		
Thermal resistance, junction-to-ambient	Steady state	$R_{\theta JA}$	40			

3. Electrical characteristics

Electrical characteristics						
Parameter	Symbol	Test conditions	Min.	Typ.	Max.	Unit
Static parameter						
Drain to source breakdown voltage	$V_{(BR)DSS}$	$V_{GS} = 0\text{ V}, I_D = 10\text{ mA}$	650			V
Gate-source threshold voltage	$V_{GS(th)}$	$V_{DS} = V_{GS}, I_D = 1\text{ mA}$	3	4	5	V
Gate-body leakage	I_{GSS}	$V_{DS} = 0\text{ V}, V_{GS} = \pm 30\text{ V}$			±100	nA
Zero gate voltage drain current	I_{DSS}	$V_{DS} = 650\text{ V}, V_{GS} = 0\text{ V}$			10	μA
Drain-source on-resistance	$R_{DS(on)}$	$V_{GS} = 10\text{ V}, I_D = 17\text{ A}$		60	70	mΩ
Gate resistance	R_g	$f = 1\text{ MHz}, \text{open drain}$		1		Ω
Dynamic ⁽⁴⁾						
Total gate charge	Q_g	$V_{DS} = 400\text{ V}, I_D = 17\text{ A}, V_{GS} = 10\text{ V}$		76.3		nC
Gate-source charge	Q_{gs}			22		
Gate-drain charge	Q_{gd}			24		
Turn-on delay time	$t_{d(on)}$	$V_{DS} = 400\text{ V}, I_D = 17\text{ A}, V_{GS} = 10\text{ V},$ $R_{GEN} = 6.8\text{ }\Omega$		48.5		ns
Rise time	t_r			13		
Turn-off delay time	$t_{d(off)}$			75.3		
Fall time	t_f			5		
Input capacitance	C_{iss}	$V_{DS} = 400\text{ V}, V_{GS} = 0\text{ V}, f = 100\text{ KHz}$		4096		pF
Output capacitance	C_{oss}			84		
Reverse transfer capacitance	C_{rss}			5		
Energy related output capacitance	$C_{oss(er.)}$	$V_{DS} = 0\text{ V to } 400\text{ V}, V_{GS} = 0\text{ V}$		127		
Reverse Diode Characteristics ⁽⁴⁾						
Diode forward voltage	V_{SD}	$V_{GS} = 0\text{ V}, I_F = 34\text{ A}$		0.87	1.1	V
Reverse recovery time	t_{rr}	$V_{DS} = 400\text{ V}, I_F = 17\text{ A}, di/dt = 100\text{ A}/\mu\text{s}$		128		ns
Reverse recovery charge	Q_{rr}			664		nC

Notes

- (1) Limited by maximum junction temperature.
- (2) Pulse width limited by maximum junction temperature.
- (3) $V_{DS} = 130\text{ V}, V_{GS} = 10\text{ V}, L = 60\text{ mH}$.
- (4) Guaranteed by design, not subject to production testing.

4. Electrical characteristics diagrams

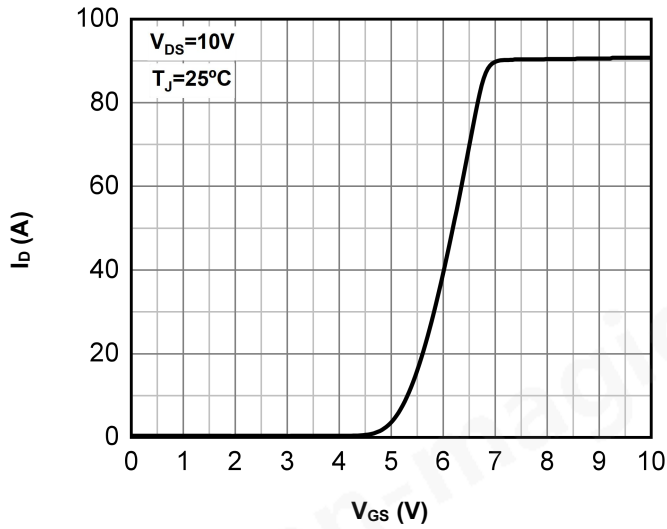
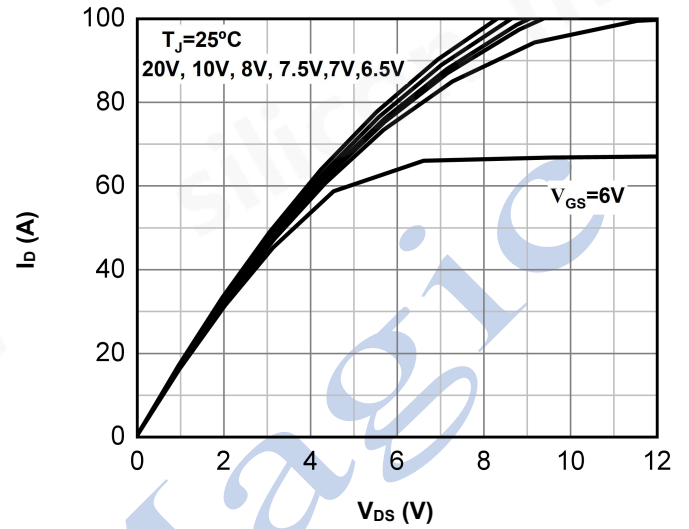
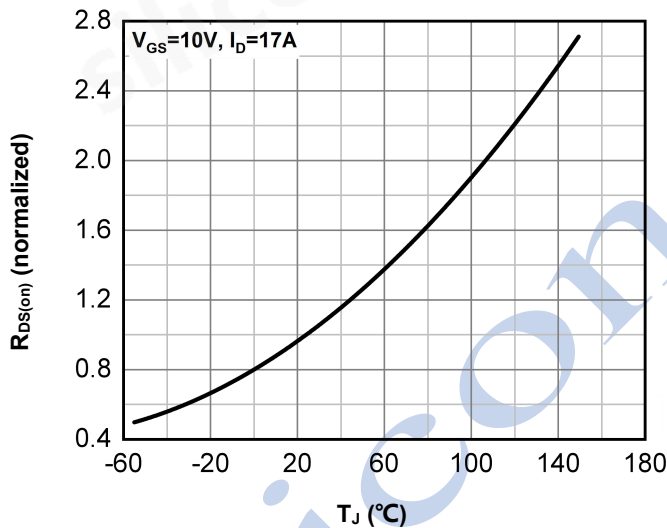
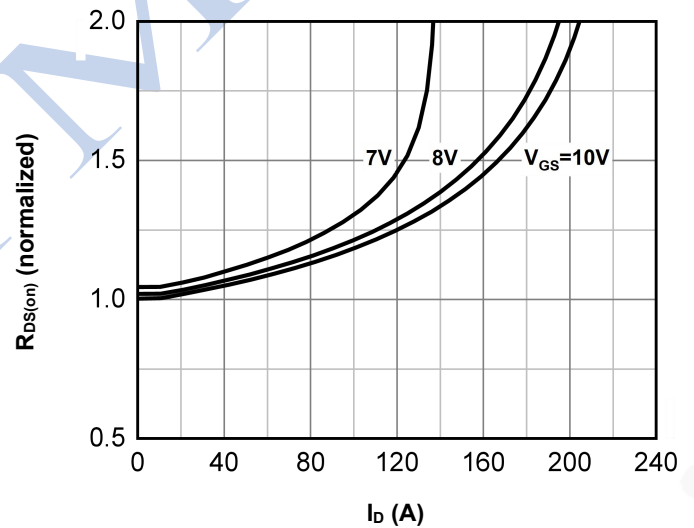
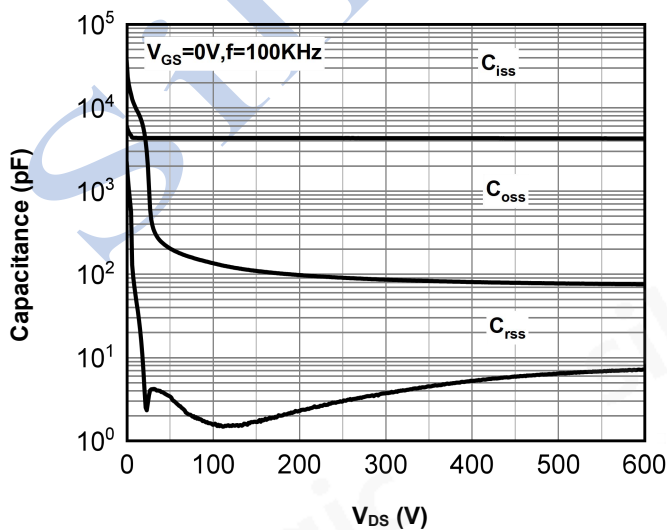
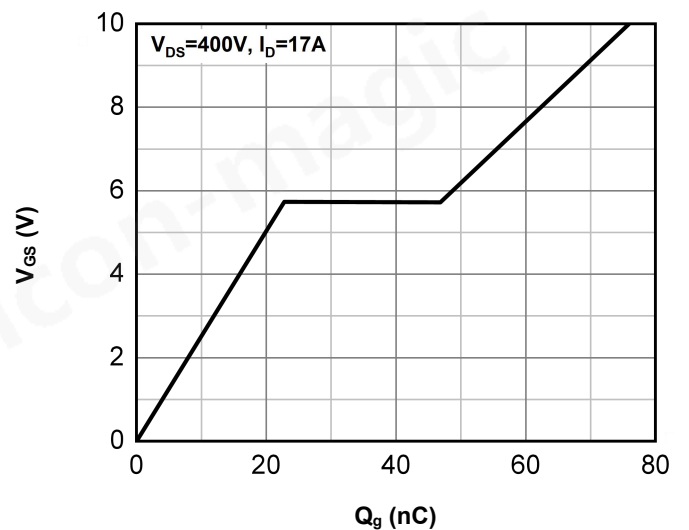
Fig.1 Typ. transfer characteristics

Fig.2 Typ. output characteristics at 25°C

Fig.3 Normalized on-resistance vs junction temperature

Fig.4 Normalized on-resistance vs drain current

Fig.5 Typ. capacitance

Fig.6 Typ. gate charge


Fig.7 Typ. forward characteristics of body diode

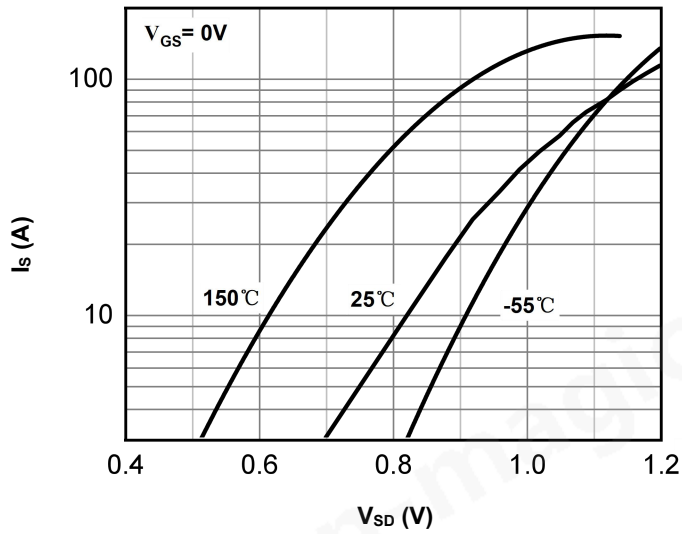


Fig.8 Safe operating area

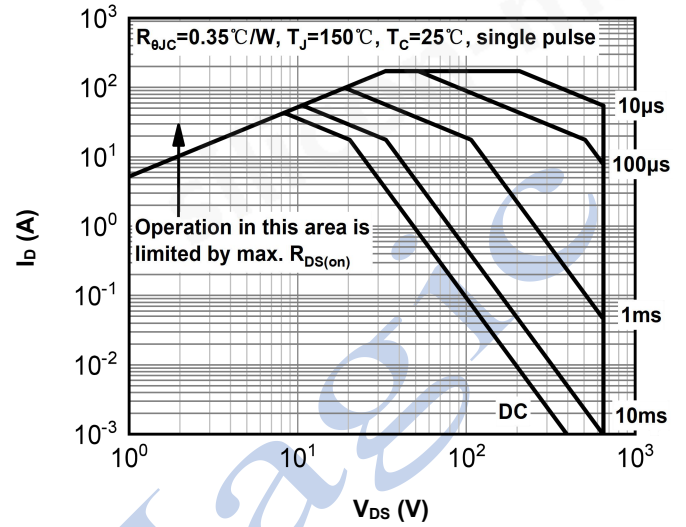


Fig.9 Drain current vs case temperature

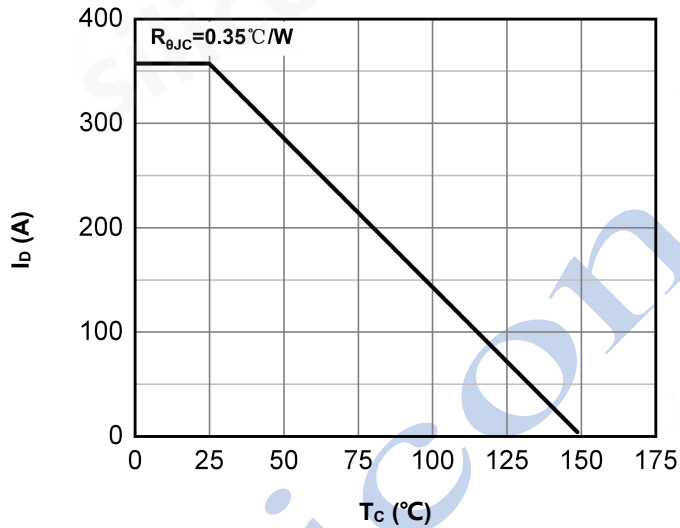


Fig.10 Typ. C_{oss} stored energy

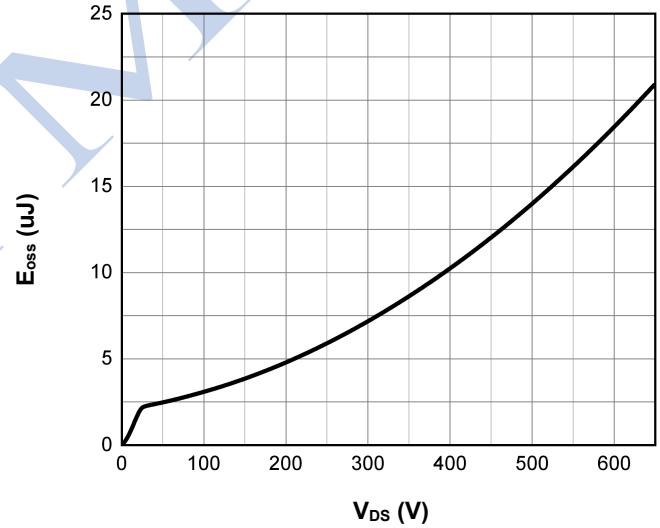


Fig.11 Normalized $V_{(BR)DSS}$ vs junction temperature

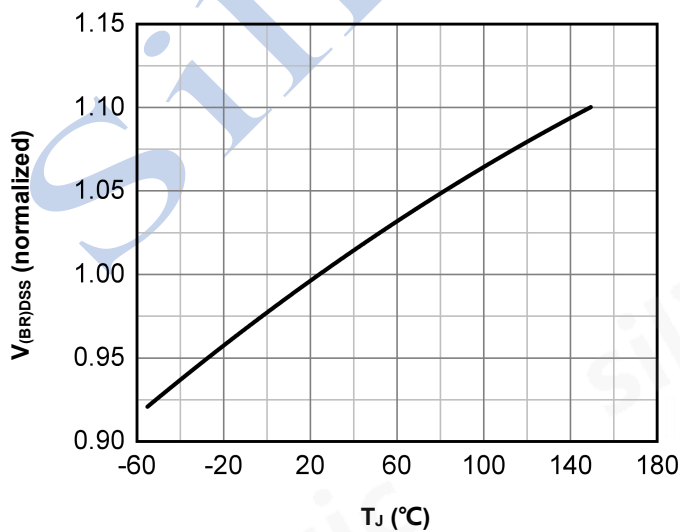


Fig.12 Normalized $V_{GS(th)}$ vs junction temperature

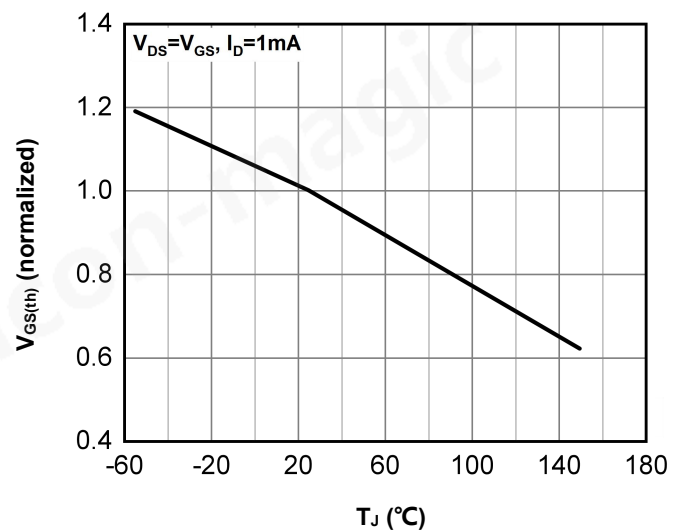
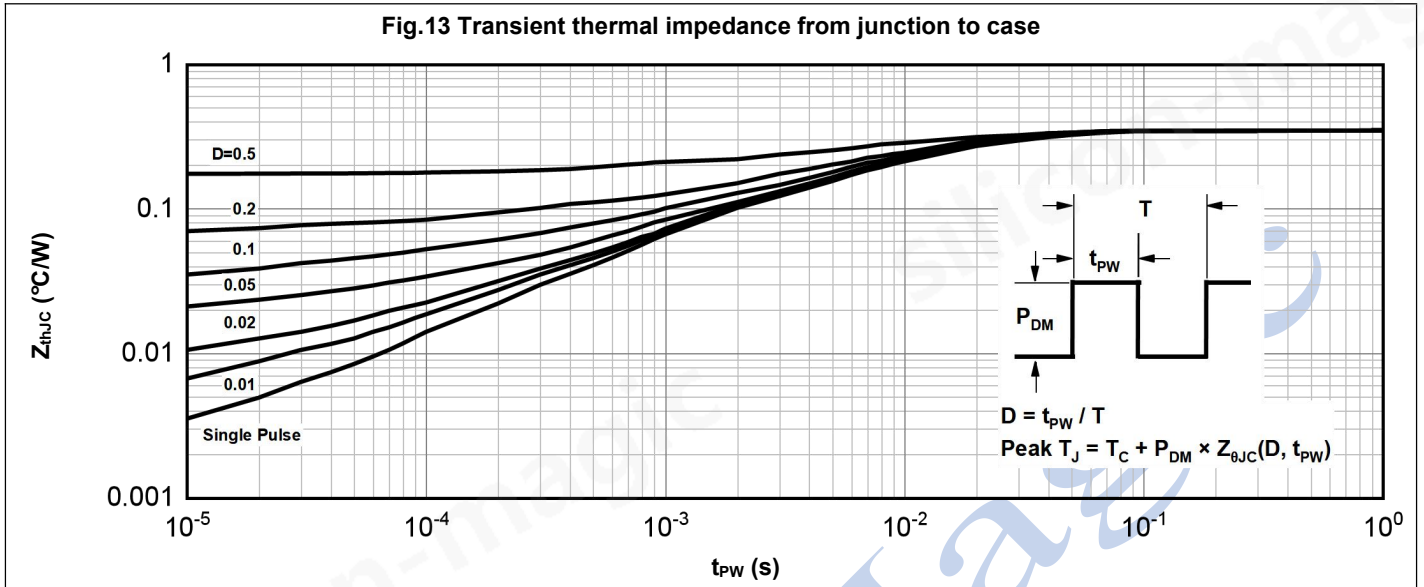


Fig.13 Transient thermal impedance from junction to case



5. Test circuits and waveforms

Figure 14. Gate charge test circuit & waveforms

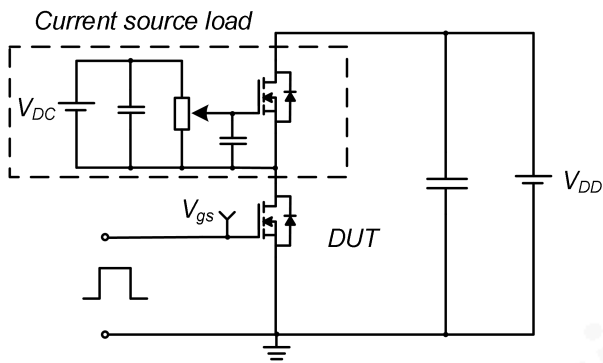


Figure 15. Switching time test circuit & waveforms

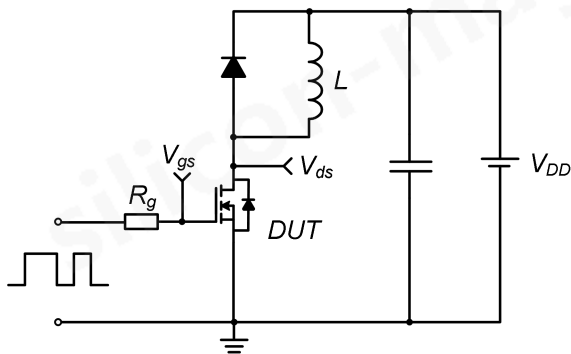


Figure 16. Diode reverse recovery test circuit & waveforms

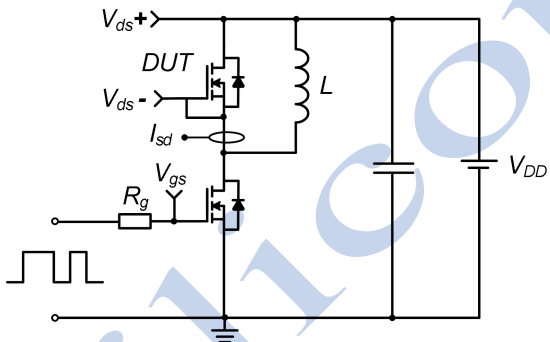
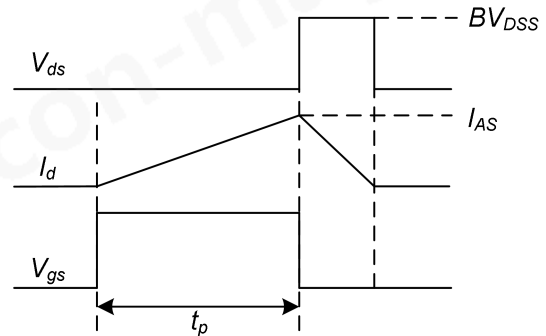
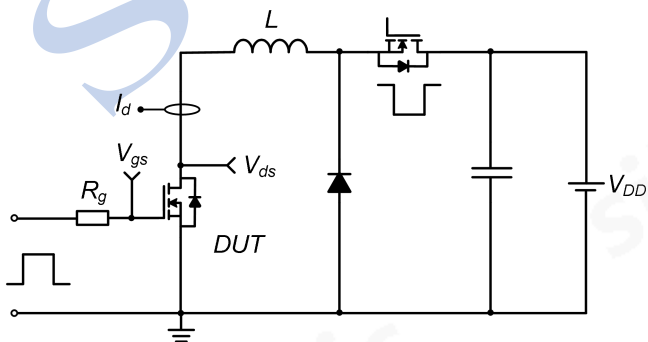
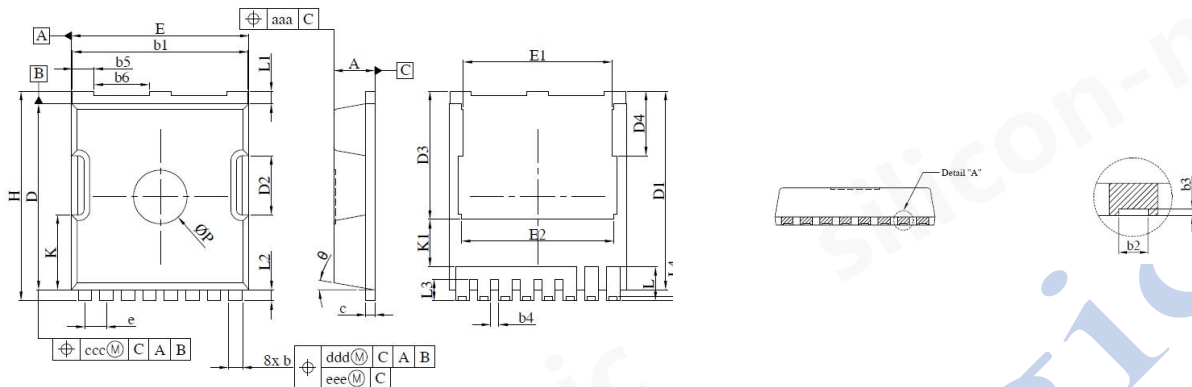


Figure 17. Unclamped inductive switching test circuit & waveforms



6. Package outline dimensions



Dim	Millimeters		
	Min	Nom	Max
A	2.20	2.30	2.40
b	0.70	0.80	0.90
b1	9.70	9.80	9.90
b2	0.36	0.45	0.55
b3	0.05	0.10	0.35
b4	0.30	0.40	0.50
b5	1.10	1.20	1.30
b6	3.00	3.10	3.20
c	0.40	0.50	0.60
D	10.28	10.38	10.55
D1	10.98	11.08	11.18
D2	3.20	3.30	3.40
D3	7.00	7.15	7.30
D4	3.44	3.59	3.74
e	1.10	1.20	1.30
E	9.80	9.90	10.00
E1	8.20	8.30	8.40
E2	8.35	8.50	8.65
H	11.50	11.68	11.85
K	4.08	4.18	4.28
K1	2.45	-	-
L	1.60	1.90	2.10
L1	0.50	0.70	0.90
L2	0.50	0.60	0.70
L3	1.00	1.20	1.30
L4	0.13	0.23	0.33
P	2.85	3.00	3.15
ø	10° REF		
aaa	0.20		
ccc	0.20		
ddd	0.25		
eee	0.20		

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